

Notice of References Cited

Application/Control No.

09/492,789

Applicant(s)/Patent Under

Reexamination

YANO ET AL.

Examiner

Leland R. Jorgensen

Art Unit

2675

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	The Electrical Engineering Handbook, CRC Press, 1993, p. 545 – 580
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.